# Quad 2:1 Multiplexer/ Demultiplexer Bus Switch

The ON Semiconductor 74FST3257 is a quad 2:1, high performance multiplexer/demultiplexer bus switch. The device is CMOS TTL compatible when operating between 4 and 5.5 Volts. The device exhibits extremely low  $R_{\rm ON}$  and adds nearly zero propagation delay. The device adds no noise or ground bounce to the system.

#### **Features**

- $R_{ON} < 4 \Omega$  Typical
- Less Than 0.25 ns-Max Delay Through Switch
- Nearly Zero Standby Current
- No Circuit Bounce
- Control Inputs are TTL/CMOS Compatible
- Pin-For-Pin Compatible With QS3257, FST3257, CBT3257
- All Popular Packages: SOIC-16, TSSOP-16, QSOP-16
- Pb-Free Packages are Available

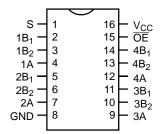


Figure 1. 16-Lead Pinout

| S           | ŌĒ          | Function                       |
|-------------|-------------|--------------------------------|
| X<br>L<br>H | H<br>L<br>L | Disconnect $A = B_1$ $A = B_2$ |

Figure 2. Truth Table



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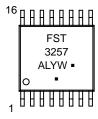
MARKING DIAGRAMS





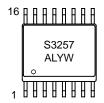


TSSOP-16 DT SUFFIX CASE 948F





QSOP-16 QS SUFFIX CASE 492



A = Assembly Location

WL, L = Wafer Lot Y = Year WW, W = Work Week • Pb-Free Package

(Note: Microdot may be in either location)

#### **PIN NAMES**

| Pin                                                               | Description        |
|-------------------------------------------------------------------|--------------------|
| $\overline{OE}_1$ , $\overline{OE}_2$                             | Bus Switch Enables |
| S <sub>0</sub> , S <sub>1</sub>                                   | Select Inputs      |
| Α                                                                 | Bus A              |
| B <sub>1</sub> , B <sub>2</sub> , B <sub>3</sub> , B <sub>4</sub> | Bus B              |

# **ORDERING INFORMATION**

See detailed ordering and shipping information in the package dimensions section on page 2 of this data sheet.

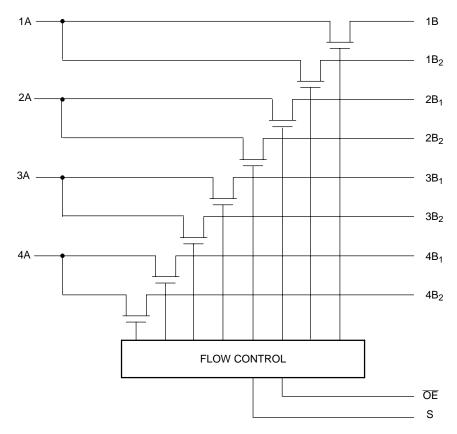


Figure 3. Logic Diagram

# **ORDERING INFORMATION**

| Device Order Number | Package              | Shipping <sup>†</sup>    |
|---------------------|----------------------|--------------------------|
| 74FST3257D          | SOIC-16              | 48 Units / Rail          |
| 74FST3257DR2        | SOIC-16              | 2500 Units / Tape & Reel |
| 74FST3257DR2G       | SOIC-16<br>(Pb-Free) | 2500 Units / Tape & Reel |
| 74FST3257DT         | TSSOP-16*            | 96 Units / Rail          |
| 74FST3257DTR2       | TSSOP-16*            | 2500 Units / Tape & Reel |
| 74FST3257DTR2G      | TSSOP-16*            | 2500 Units / Tape & Reel |
| 74FST3257QS         | QSOP-16              | 96 Units / Rail          |
| 74FST3257QSR        | QSOP-16              | 2500 Units / Tape & Reel |

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.
\*This package is inherently Pb–Free.

#### **MAXIMUM RATINGS**

| Symbol               | Parameter                                                                                               | Value                | Unit |
|----------------------|---------------------------------------------------------------------------------------------------------|----------------------|------|
| V <sub>CC</sub>      | DC Supply Voltage                                                                                       | -0.5  to  +7.0       | V    |
| VI                   | DC Input Voltage                                                                                        | -0.5  to  +7.0       | V    |
| Vo                   | DC Output Voltage                                                                                       | -0.5  to  +7.0       | V    |
| I <sub>IK</sub>      | DC Input Diode Current $V_1 < GND$                                                                      | -50                  | mA   |
| I <sub>OK</sub>      | DC Output Diode Current $V_{O} < GND$                                                                   | -50                  | mA   |
| ΙO                   | DC Output Sink Current                                                                                  | 128                  | mA   |
| I <sub>CC</sub>      | DC Supply Current per Supply Pin                                                                        | ±100                 | mA   |
| I <sub>GND</sub>     | DC Ground Current per Ground Pin                                                                        | ±100                 | mA   |
| T <sub>STG</sub>     | Storage Temperature Range                                                                               | -65 to +150          | °C   |
| TL                   | Lead Temperature, 1 mm from Case for 10 Seconds                                                         | 260                  | °C   |
| TJ                   | Junction Temperature Under Bias                                                                         | + 150                | °C   |
| $\theta_{\sf JA}$    | Thermal Resistance SOIC TSSOP QSOP                                                                      | 125<br>170<br>200    | °C/W |
| MSL                  | Moisture Sensitivity                                                                                    | Level 1              |      |
| F <sub>R</sub>       | Flammability Rating Oxygen Index: 28 to 34                                                              | UL 94 V-0 @ 0.125 in |      |
| V <sub>ESD</sub>     | ESD Withstand Voltage  Human Body Model (Note 1)  Machine Model (Note 2)  Charged Device Model (Note 3) | >2000<br>>200<br>N/A | V    |
| I <sub>Latchup</sub> | Latchup Performance Above V <sub>CC</sub> and Below GND at 85°C (Note 4)                                | ±500                 | mA   |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- 1. Tested to EIA/JESD22-A114-A.
- 2. Tested to EIA/JESD22-A115-A.
- 3. Tested to JESD22-C101-A.
- 4. Tested to EIA/JESD78.

# **RECOMMENDED OPERATING CONDITIONS**

| Symbol          | Parameter                                        |                                                                 |     | Max     | Unit |
|-----------------|--------------------------------------------------|-----------------------------------------------------------------|-----|---------|------|
| V <sub>CC</sub> | Supply Voltage                                   | Operating, Data Retention Only                                  | 4.0 | 5.5     | V    |
| VI              | Input Voltage                                    | (Note 5)                                                        | 0   | 5.5     | V    |
| Vo              | Output Voltage                                   | (HIGH or LOW State)                                             | 0   | 5.5     | V    |
| T <sub>A</sub>  | Operating Free-Air Temperature                   |                                                                 | -40 | +85     | °C   |
| Δt/ΔV           | Input Transition Rise or Fall Rate<br>Switch I/O | Switch Control Input $V_{CC} = 5.0 \text{ V} \pm 0.5 \text{ V}$ | 0   | DC<br>5 | ns/V |

5. Unused control inputs may not be left open. All control inputs must be tied to a high or low logic input voltage level.

#### DC ELECTRICAL CHARACTERISTICS

|                  |                                       |                                                               | V <sub>CC</sub> | T <sub>A</sub> = | −40°C to ⊣ | ⊦85°C |      |
|------------------|---------------------------------------|---------------------------------------------------------------|-----------------|------------------|------------|-------|------|
| Symbol           | Parameter                             | Conditions                                                    | (V)             | Min              | Тур*       | Max   | Unit |
| V <sub>IK</sub>  | Clamp Diode Resistance                | $I_{IN} = -18mA$                                              | 4.5             |                  |            | -1.2  | V    |
| V <sub>IH</sub>  | High-Level Input Voltage              |                                                               | 4.0 to 5.5      | 2.0              |            |       | V    |
| V <sub>IL</sub>  | Low-Level Input Voltage               |                                                               | 4.0 to 5.5      |                  |            | 0.8   | V    |
| l <sub>l</sub>   | Input Leakage Current                 | $0 \le V_{IN} \le 5.5 V$                                      | 5.5             |                  |            | ±1.0  | μΑ   |
| I <sub>OZ</sub>  | Off-State Leakage Current             | $0 \le A, B \le V_{CC}$                                       | 5.5             |                  |            | ±1.0  | μΑ   |
| R <sub>ON</sub>  | Switch On Resistance (Note 6)         | V <sub>IN</sub> = 0 V, I <sub>IN</sub> = 64 mA                | 4.5             |                  | 4          | 7     | Ω    |
|                  |                                       | V <sub>IN</sub> = 0 V, I <sub>IN</sub> = 30 mA                | 4.5             |                  | 4          | 7     |      |
|                  |                                       | V <sub>IN</sub> = 2.4 V, I <sub>IN</sub> = 15 mA              | 4.5             |                  | 8          | 15    |      |
|                  |                                       | V <sub>IN</sub> = 2.4 V, I <sub>IN</sub> = 15 mA              | 4.0             |                  | 11         | 20    |      |
| I <sub>CC</sub>  | Quiescent Supply Current              | $V_{IN} = V_{CC}$ or GND, $I_{OUT} = 0$                       | 5.5             |                  |            | 3     | μΑ   |
| Δl <sub>CC</sub> | Increase In I <sub>CC</sub> per Input | One input at 3.4 V,<br>Other inputs at V <sub>CC</sub> or GND | 5.5             |                  |            | 2.5   | mA   |

#### **AC ELECTRICAL CHARACTERISTICS**

|                    |                                                  | $T_A = -40$ °C to +85 °C $C_L = 50$ pF, RU = RD = 500 |                     |          |                   |       |      |
|--------------------|--------------------------------------------------|-------------------------------------------------------|---------------------|----------|-------------------|-------|------|
|                    |                                                  |                                                       | V <sub>CC</sub> = 4 | .5–5.5 V | V <sub>CC</sub> = | 4.0 V |      |
| Symbol             | Parameter                                        | Conditions                                            | Min                 | Max      | Min               | Max   | Unit |
| t <sub>PHL</sub> , | Prop Delay Bus to Bus (Note 7)                   | V <sub>I</sub> = OPEN                                 |                     | 0.25     |                   | 0.25  | ns   |
| <sup>t</sup> PLH   | Prop Delay, Select to Bus A                      |                                                       | 1.0                 | 4.7      |                   | 5.2   |      |
| t <sub>PZH</sub> , | Output Enable Time, Select to Bus B              | $V_I = 7 \text{ V for } t_{PZL}$                      | 1.0                 | 5.2      |                   | 5.7   | ns   |
| t <sub>PZL</sub>   | Output Enable Time, I <sub>OE</sub> to Bus A, B  | V <sub>I</sub> = OPEN for t <sub>PZH</sub>            | 1.0                 | 5.1      |                   | 5.6   |      |
| t <sub>PHZ</sub> , | Output Disable Time, Select to Bus B             | $V_I = 7 \text{ V for } t_{PLZ}$                      | 1.0                 | 5.2      |                   | 5.5   | ns   |
| t <sub>PLZ</sub>   | Output Disable Time, I <sub>OE</sub> to Bus A, B | V <sub>I</sub> = OPEN for t <sub>PHZ</sub>            | 1.0                 | 5.5      |                   | 5.5   |      |

<sup>7.</sup> This parameter is guaranteed by design but is not tested. The bus switch contributes no propagation delay other than the RC delay of the typical On resistance of the switch and the 50 pF load capacitance, when driven by an ideal voltage source (zero output impedance).

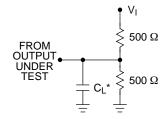
# **CAPACITANCE** (Note 8)

| Symbol           | Parameter                       | Conditions                                 | Тур | Max | Unit |
|------------------|---------------------------------|--------------------------------------------|-----|-----|------|
| C <sub>IN</sub>  | Control Pin Input Capacitance   | V <sub>CC</sub> = 5.0 V                    | 3   |     | pF   |
| C <sub>I/O</sub> | A Port Input/Output Capacitance | $V_{CC}$ , $\overline{OE} = 5.0 \text{ V}$ | 7   |     | pF   |
| C <sub>I/O</sub> | B Port Input/Output Capacitance | $V_{CC}$ , $\overline{OE} = 5.0 \text{ V}$ | 5   |     | pF   |

<sup>8.</sup>  $T_A = +25$ °C, f = 1 MHz, Capacitance is characterized but not tested.

<sup>\*</sup>Typical values are at V<sub>CC</sub> = 5.0 V and T<sub>A</sub> = 25°C.
6. Measured by the voltage drop between A and B pins at the indicated current through the switch. On resistance is determined by the lower of the voltages on the two (A or B) pins.

# **AC Loading and Waveforms**



# NOTES:

- 1. Input driven by 50  $\Omega$  source terminated in 50  $\Omega.$
- 2. CL includes load and stray capacitance.
- ${}^{*}C_{L} = 50 pF$

Figure 4. AC Test Circuit

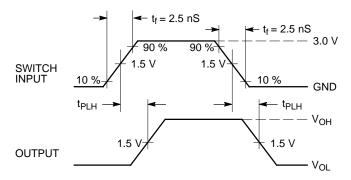


Figure 5. Propagation Delays

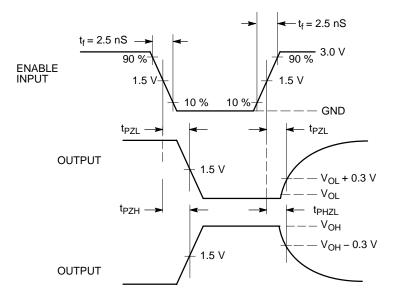
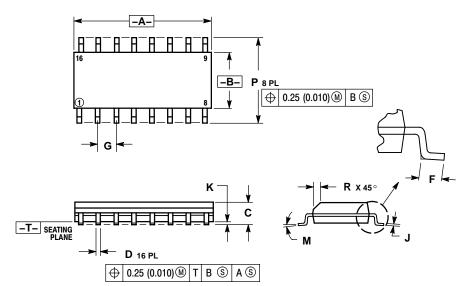


Figure 6. Enable/Disable Delays

# **PACKAGE DIMENSIONS**

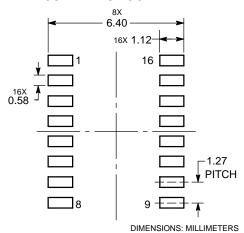
# SOIC-16 **D SUFFIX** CASE 751B-05 ISSUE K



- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
  2. CONTROLLING DIMENSION: MILLIMETER.
  3. DIMENSIONS A AND B DO NOT INCLUDE MOLD PROTRUSION.
  4. MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE.
  5. DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION. SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.

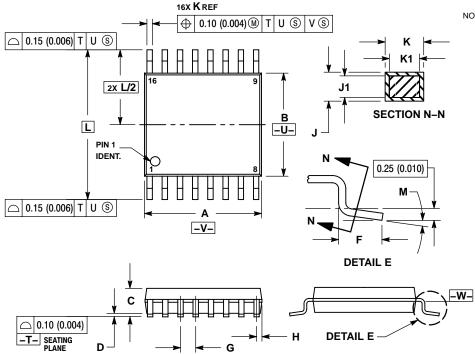
|     | MILLIMETERS |       | INCHES |       |
|-----|-------------|-------|--------|-------|
| DIM | MIN         | MAX   | MIN    | MAX   |
| Α   | 9.80        | 10.00 | 0.386  | 0.393 |
| В   | 3.80        | 4.00  | 0.150  | 0.157 |
| С   | 1.35        | 1.75  | 0.054  | 0.068 |
| D   | 0.35        | 0.49  | 0.014  | 0.019 |
| F   | 0.40        | 1.25  | 0.016  | 0.049 |
| G   | 1.27 BSC    |       | 0.050  | BSC   |
| J   | 0.19        | 0.25  | 0.008  | 0.009 |
| K   | 0.10        | 0.25  | 0.004  | 0.009 |
| M   | 0°          | 7°    | 0°     | 7°    |
| P   | 5.80        | 6.20  | 0.229  | 0.244 |
| R   | 0.25        | 0.50  | 0.010  | 0.019 |

#### **SOLDERING FOOTPRINT**



#### **PACKAGE DIMENSIONS**

# TSSOP-16 **DT SUFFIX** CASE 948F-01 **ISSUE B**



- NOTES:

  1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
  2. CONTROLLING DIMENSION: MILLIMETER.
  3. DIMENSION A DOES NOT INCLUDE MOLD FLASH. PROTRUSIONS OR GATE BURRS. MOLD FLASH OR GATE BURRS SHALL NOT EXCEED 0.15 (0.06) PER SIDE
  - EXCEED 0.15 (0.006) PER SIDE.

    4. DIMENSION B DOES NOT INCLUDE 4. DIMENSION B DUES NOT INCLUDE INTERLEAD FLASH OR PROTRUSION. INTERLEAD FLASH OR PROTRUSION SHALL NOT EXCEED 0.25 (0.010) PER SIDE. 5. DIMENSION K DOES NOT INCLUDE
  - DAMBAR PROTRUSION. ALLOWABLE
    DAMBAR PROTRUSION SHALL BE 0.08 (0.003) TOTAL IN EXCESS OF THE K
    DIMENSION AT MAXIMUM MATERIAL
    CONDITION.

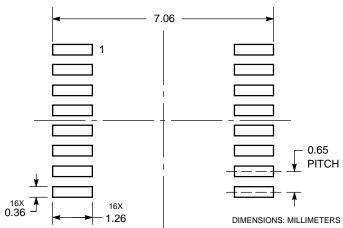
  - CONDITION.

    6. TERMINAL NUMBERS ARE SHOWN FOR REFERENCE ONLY.

    7. DIMENSION A AND B ARE TO BE DETERMINED AT DATUM PLANE –W–.

|     | MILLIN | IETERS | INC       | HES   |
|-----|--------|--------|-----------|-------|
| DIM | MIN    | MAX    | MIN       | MAX   |
| Α   | 4.90   | 5.10   | 0.193     | 0.200 |
| В   | 4.30   | 4.50   | 0.169     | 0.177 |
| С   |        | 1.20   |           | 0.047 |
| D   | 0.05   | 0.15   | 0.002     | 0.006 |
| F   | 0.50   | 0.75   | 0.020     | 0.030 |
| G   | 0.65   | BSC    | 0.026     | BSC   |
| Н   | 0.18   | 0.28   | 0.007     | 0.011 |
| J   | 0.09   | 0.20   | 0.004     | 0.008 |
| J1  | 0.09   | 0.16   | 0.004     | 0.006 |
| K   | 0.19   | 0.30   | 0.007     | 0.012 |
| K1  | 0.19   | 0.25   | 0.007     | 0.010 |
| L   | 6.40   |        | 0.252 BSC |       |
| M   | 0 °    | 8°     | 0°        | 8 °   |

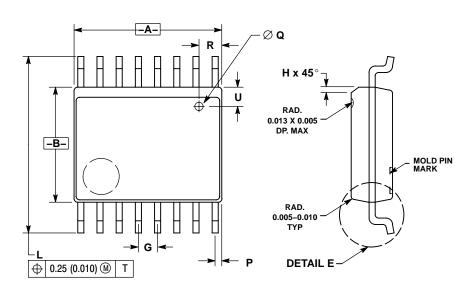
#### **SOLDERING FOOTPRINT**

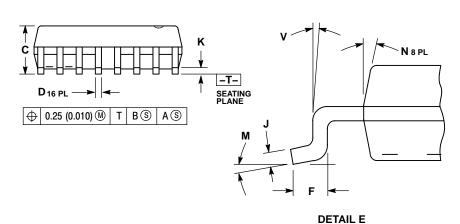


#### PACKAGE DIMENSIONS

# QSOP-16 **QS SUFFIX**

CASE 492-01 **ISSUE O** 





#### NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- 114.3W, 1992.
  CONTROLLING DIMENSION: INCH.
  THE BOTTOM PACKAGE SHALL BE BIGGER THAN
  THE TOP PACKAGE BY 4 MILS (NOTE: LEAD SIDE
  ONLY). BOTTOM PACKAGE DIMENSION SHALL FOLLOW THE DIMENSION STATED IN THIS DRAWING
- PLASTIC DIMENSIONS DOES NOT INCLUDE MOLD FLASH OR PROTRUSIONS. MOLD FLASH OR PROTRUSIONS SHALL NOT EXCEED 6 MILS PER
- BOTTOM EJECTOR PIN WILL INCLUDE THE COUNTRY OF ORIGIN (COO) AND MOLD CAVITY I.D.

|     | INCHES |        | MILLIM   | ETERS |
|-----|--------|--------|----------|-------|
| DIM | MIN    | MAX    | MIN      | MAX   |
| Α   | 0.189  | 0.196  | 4.80     | 4.98  |
| В   | 0.150  | 0.157  | 3.81     | 3.99  |
| С   | 0.061  | 0.068  | 1.55     | 1.73  |
| D   | 0.008  | 0.012  | 0.20     | 0.31  |
| F   | 0.016  | 0.035  | 0.41     | 0.89  |
| G   | 0.025  | BSC    | 0.64     | BSC   |
| Н   | 0.008  | 0.018  | 0.20     | 0.46  |
| J   | 0.0098 | 0.0075 | 0.249    | 0.191 |
| K   | 0.004  | 0.010  | 0.10     | 0.25  |
| L   | 0.230  | 0.244  | 5.84     | 6.20  |
| M   | 0°     | 8°     | 0°       | 8°    |
| N   | 0°     | 7°     | 0°       | 7°    |
| P   | 0.007  | 0.011  | 0.18     | 0.28  |
| Q   | 0.020  | DIA    | 0.51 DIA |       |
| R   | 0.025  | 0.035  | 0.64     | 0.89  |
| U   | 0.025  | 0.035  | 0.64     | 0.89  |
| ٧   | 0 °    | 8°     | 0°       | 8 °   |

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